

Notice of References Cited	Application/Control No. 10/715,774	Applicant(s)/Patent Under Reexamination AHN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,917,646	06-1999	Sheridon, Nicholas K.	359/296
*	B	US-6,704,133	03-2004	Gates et al.	359/296
*	C	US-6,738,050	05-2004	Comiskey et al.	345/173
*	D	US-6,816,146	11-2004	Harada et al.	345/107
*	E	US-2002/0130832	09-2002	Baucom et al.	345/107
*	F	US-2003/0016429	01-2003	Ikeda et al.	359/238
*	G	US-2003/0016429	01-2003	Ikeda et al.	359/238
*	H	US-6,577,433	06-2003	Lin et al.	359/296
*	I	US-6,781,745	08-2004	Chung et al.	359/296
*	J	US-2002/0141801	10-2002	SHIMODA et al.	400/76
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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